60 V, 16-bit high-precision power monitor with I²C and MIPI I3C interface

**Features**

- 16-bit resolution dual-channel sigma-delta ADC
- 2.7 V to 3.6 V power supply voltage
- From 128 µs to 32.7 ms total conversion time
- Bidirectional current, high-side, or low-side sensing
- Load voltage sensing from 0 V to 60 V
- Ultra-low input bias current: 20 pA typical at $V_{CM} = 12$ V
- Ultra-low shutdown current: 50 nA typical
- Shunt offset voltage: ±3 µV typical
- Shunt and load voltage gain error: 0.5% maximum
- Internal die temperature monitoring
- MIPI I3C up to 12.5 MHz
- I²C bus interface up to 1 MHz
- Default I²C address: 1000000(b) to 1000011(b)
- SMBus alert compatible
- Alert signals generated in case of over/undervoltage, over/undercurrent, overpower, or overtemperature
- Extended temperature range: -40 °C to 125 °C
- DFN10 3 x 3 mm² package

**Applications**

- Industrial battery packs
- Power inverters
- DC power supplies
- Data centers
- Telecom equipment
- Power tools

**Description**

The TSC1641 is a high-precision current, voltage power, and temperature monitoring analog front-end (AFE). It monitors current into a shunt resistor and load voltage up to 60 V in a synchronized way. The current measurement can be high-side, low-side, and bidirectional.

The device integrates high-precision 16-bit dual-channel ADC with a programmable conversion time from 128 µs to 32.7 ms.

Digital bus interface is flexible from I²C/SMbus 1 MHz data rate to MIPI I3C 12.5 MHz data rate. This allows connectivity to most of the recent STM32 products.

The TSC1641 allows the assertion of several alerts regarding the voltage, current, power and temperature. Thresholds can be set for each parameter in a specific register.

The TSC1641 comes in a plastic DFN10 package and can operate from -40 °C to 125 °C ambient temperature.
1 Block diagram and pin description

Figure 1. Block diagram

Figure 2. Pin connections (top view – not to scale)

Table 1. Pin description

<table>
<thead>
<tr>
<th>Pin</th>
<th>Pin name</th>
<th>Type</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>A1</td>
<td>Digital input</td>
<td>I²C mode: A1 is a digital input to select the address of the target. See Table 6 for pin settings and the corresponding addresses. I3C mode: A1 is used to set static address (priority vs. virtual address).</td>
</tr>
<tr>
<td>2</td>
<td>A0</td>
<td>Digital input</td>
<td>I²C mode: A0 is a digital input to select the address of the target. See Table 6 for pin settings and the corresponding addresses. I3C mode: A0 is used to set static address (priority vs. virtual address).</td>
</tr>
<tr>
<td>3</td>
<td>ALERT/DRDY</td>
<td>Digital output</td>
<td>Multi-functional digital alert pin. Open-drain output in I²C. To be connected with a pull-up resistor. Not connected in I3C. Default state is active-low.</td>
</tr>
<tr>
<td>4</td>
<td>SDA</td>
<td>Digital input/output</td>
<td>Digital I/O, serial bus data line, open-drain input/output in I²C/SMbus, open-drain or push-pull in MIPI I3C mode.</td>
</tr>
<tr>
<td>5</td>
<td>SCL</td>
<td>Digital input</td>
<td>Digital input, serial bus clock line.</td>
</tr>
<tr>
<td>6</td>
<td>VS</td>
<td>Power supply</td>
<td>Power supply for the device, range is 2.7 V to 3.6 V.</td>
</tr>
<tr>
<td>7</td>
<td>GND</td>
<td>Ground</td>
<td>Ground reference point.</td>
</tr>
<tr>
<td>8</td>
<td>VLOAD</td>
<td>Analog input</td>
<td>Analog input, the load voltage input from 0 V to 60 V.</td>
</tr>
<tr>
<td>9</td>
<td>IN-</td>
<td>Analog input</td>
<td>Analog input, lower side of the shunt resistor.</td>
</tr>
<tr>
<td>10</td>
<td>IN+</td>
<td>Analog input</td>
<td>Analog input, upper side of the shunt resistor.</td>
</tr>
<tr>
<td>-</td>
<td>Exposed pad</td>
<td>-</td>
<td>No electrical connection. Should be left floating.</td>
</tr>
</tbody>
</table>
2 Absolute maximum ratings and operation conditions

Table 2. Absolute maximum ratings

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Value</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_S$ (1)</td>
<td>Maximum supply voltage</td>
<td>-0.3 to 7</td>
<td>V</td>
</tr>
<tr>
<td>$V_i$</td>
<td>Maximum applied voltage on digital inputs</td>
<td>-0.3 to 7</td>
<td>V</td>
</tr>
<tr>
<td>$V_{\text{LOAD}}$</td>
<td>Load power supply maximum voltage</td>
<td>-0.3 to 65</td>
<td>V</td>
</tr>
<tr>
<td>$V_{\text{IN},\text{D}}$</td>
<td>Differential voltage between IN+ and IN-</td>
<td>-65 to 65</td>
<td>V</td>
</tr>
<tr>
<td>$V_{\text{IN},\text{IN}}$</td>
<td>Maximum analog input voltage on IN+, IN-</td>
<td>0 to 65</td>
<td>V</td>
</tr>
<tr>
<td>$T_{\text{stg}}$</td>
<td>Maximum storage temperature</td>
<td>-65 to 150</td>
<td>°C</td>
</tr>
<tr>
<td>$T_j$</td>
<td>Maximum junction temperature</td>
<td>+150</td>
<td>°C</td>
</tr>
<tr>
<td>$R_{\text{thja}}$</td>
<td>Junction to ambient thermal resistance (for DFN10)</td>
<td>76</td>
<td>°C/W</td>
</tr>
<tr>
<td></td>
<td>On a 2S2P JEDEC board, as per JESD51-9, area of 8.7 cm²</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$R_{\text{thjc}}$</td>
<td>Junction to case thermal resistance (for DFN10)</td>
<td>1</td>
<td>°C/W</td>
</tr>
<tr>
<td>$I_{\text{i}}$ (2)</td>
<td>Maximum input current applied on any pin</td>
<td>±10</td>
<td>mA</td>
</tr>
<tr>
<td>$I_{\text{out}}$</td>
<td>Maximum open-drain digital output current</td>
<td>10</td>
<td>mA</td>
</tr>
<tr>
<td>$E_{\text{SD}}$</td>
<td>Human body model (HBM)</td>
<td>2000</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td>Charged device model (CDM)</td>
<td>500</td>
<td>V</td>
</tr>
</tbody>
</table>

1. All voltages are with respect to the network ground terminal.
2. When the input voltage of any pin exceeds the power supplies (that is $V_{\text{IN}} < \text{GND}$ or $V_{\text{IN}} > V_S$), the current on that pin should be limited to 10 mA. The 20 mA maximum package input current rating limits the number of pins that can safely exceed the power supply with an input current of 10 mA to two.

Table 3. Operating conditions

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Value</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_S$</td>
<td>Power supply voltage</td>
<td>2.7 to 3.6</td>
<td>V</td>
</tr>
<tr>
<td>$V_{\text{IN},\text{IN}}$</td>
<td>Analog input voltage on IN+, IN-</td>
<td>0 to 60</td>
<td>V</td>
</tr>
<tr>
<td>$T$</td>
<td>Operating free-air temperature range</td>
<td>-40 to +125</td>
<td>°C</td>
</tr>
</tbody>
</table>
3 Electrical characteristics

\[ V_S = 3.3 \text{ V}, V_{\text{SENSE}} = V_{\text{IN}^+} - V_{\text{IN}^-} = 0 \text{ V}, V_{\text{LOAD}} = 48 \text{ V}, V_{CM} = \frac{V_{\text{IN}^+} + V_{\text{IN}^-}}{2} = 0 \text{ V}, \text{Ta} = 25 \text{ °C}. \]

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameters</th>
<th>Test conditions</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>(V_{\text{SENSE}})</td>
<td>Shunt voltage input range</td>
<td></td>
<td>-81.9175</td>
<td>81.92</td>
<td></td>
<td>mV</td>
</tr>
<tr>
<td>(V_{\text{LOAD}})</td>
<td>Load voltage input range</td>
<td></td>
<td>0</td>
<td>60</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>CMRR</td>
<td>Common mode rejection</td>
<td></td>
<td>0 V \leq V_{CM} \leq 48 V</td>
<td>115</td>
<td></td>
<td>dB</td>
</tr>
<tr>
<td>SRnLoad</td>
<td>Maximum measurable negative slew-rate on load voltage</td>
<td></td>
<td></td>
<td>80</td>
<td></td>
<td>V/s</td>
</tr>
<tr>
<td>(V_O)</td>
<td>Shunt offset voltage</td>
<td></td>
<td>+/-3</td>
<td>+/-30</td>
<td></td>
<td>(\mu)V</td>
</tr>
<tr>
<td>(V_{\text{CMRR}})</td>
<td>Shunt offset voltage drift vs. temperature</td>
<td>-40 °C \leq T \leq 125 °C</td>
<td>0.2</td>
<td></td>
<td></td>
<td>(\mu)V/°C</td>
</tr>
<tr>
<td>(IB)</td>
<td>Input bias current (IN+, IN-pins)</td>
<td>(V_{CM} = 12 \text{ V})</td>
<td>20</td>
<td></td>
<td></td>
<td>pA</td>
</tr>
<tr>
<td>(V_{\text{LOAD}})</td>
<td>Load voltage gain error</td>
<td>-40 °C \leq T \leq 125 °C</td>
<td>±0.2</td>
<td>±0.5</td>
<td></td>
<td>%</td>
</tr>
<tr>
<td>(V_{\text{LOAD}})</td>
<td>Load voltage gain error vs. temperature</td>
<td>-40 °C \leq T \leq 125 °C</td>
<td>±20</td>
<td></td>
<td></td>
<td>ppm/°C</td>
</tr>
<tr>
<td>(IB)</td>
<td>Continuous conversion mode</td>
<td>(V_{CM} = 48 \text{ V})</td>
<td>70</td>
<td></td>
<td></td>
<td>pA</td>
</tr>
<tr>
<td>(V_{\text{LOAD}})</td>
<td>Load input impedance</td>
<td></td>
<td>840</td>
<td></td>
<td></td>
<td>kΩ</td>
</tr>
</tbody>
</table>

DC accuracy

- ADC native resolution: 16 Bits
- \(\text{LSB}_S\): 1 LSB step size for shunt: 2.5 \(\mu\)V
- \(\text{LSB}_L\): 1 LSB step size for load: 2 mV
- Shunt voltage gain error: \(V_{\text{IN}^-} = 0 \text{ V}, V_{\text{IN}^+} = 70 \text{ mV}\) ±0.2 ±0.5 %
- Shunt voltage gain error vs. temperature: -40 °C \leq T \leq 125 °C ±20 ppm/°C
- Load voltage gain error: ±0.2 ±0.5 %
- Load voltage gain error vs. temperature: -40 °C \leq T \leq 125 °C ±25 ppm/°C
- DNL: Differential non-linearity
  - Conversion time = 128 \(\mu\)s ± 0.5 LSB

ADC conversion time for current and voltage (1)

- Config bits CT3-CT0=0000: 128 \(\mu\)s
- Config bits CT3-CT0=0001: 256 \(\mu\)s
- Config bits CT3-CT0=0010: 512 \(\mu\)s
- Config bits CT3-CT0=0011: 1024 \(\mu\)s
- Config bits CT3-CT0=0100: 2048 \(\mu\)s
- Config bits CT3-CT0=0101: 4096 \(\mu\)s
- Config bits CT3-CT0=0110: 8192 \(\mu\)s
- Config bits CT3-CT0=0111: 16384 \(\mu\)s
- Config bits CT3-CT0=1000: 32768 \(\mu\)s

Clock source

- \(F_{\text{OSC}}\) Internal oscillator frequency: 3.8 4 4.2 MHz
### Electrical characteristics

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameters</th>
<th>Test conditions</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>SMBus</td>
<td>SMBus timeout</td>
<td>Resets the interface if SCL is low in this timing</td>
<td>25</td>
<td>35</td>
<td></td>
<td>ms</td>
</tr>
</tbody>
</table>

#### Temperature sensor characteristics

<table>
<thead>
<tr>
<th></th>
<th>Accuracy</th>
<th>Accuracy vs. temperature</th>
<th>LSB step size</th>
<th>ADC conversion time for temperature</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>+/-1</td>
<td>+/-2 °C</td>
<td>0.5 °C</td>
<td>8.192 ms</td>
</tr>
</tbody>
</table>

#### Digital characteristics

<table>
<thead>
<tr>
<th></th>
<th>Input capacitance</th>
<th>Leakage input current</th>
<th>V&lt;sub&gt;IH&lt;/sub&gt; Input high voltage</th>
<th>V&lt;sub&gt;IL&lt;/sub&gt; Input low voltage</th>
<th>V&lt;sub&gt;OL&lt;/sub&gt; Low-level output voltage</th>
<th>V&lt;sub&gt;OH&lt;/sub&gt; High-level output voltage</th>
<th>Hysteresis</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>3 pF</td>
<td>0.1 µA</td>
<td>0.7xV&lt;sub&gt;S&lt;/sub&gt;</td>
<td>GND</td>
<td>GND</td>
<td>GND</td>
<td>0.1xV&lt;sub&gt;S&lt;/sub&gt;</td>
</tr>
</tbody>
</table>

#### Power supply characteristics

<table>
<thead>
<tr>
<th>Vs</th>
<th>Operating supply range</th>
<th>2.7</th>
<th>3.3</th>
<th>3.6</th>
<th>V</th>
</tr>
</thead>
<tbody>
<tr>
<td>I&lt;sub&gt;DD&lt;/sub&gt;</td>
<td>Supply current Shutdown mode (0h) in configuration register</td>
<td>50</td>
<td></td>
<td></td>
<td>nA</td>
</tr>
<tr>
<td></td>
<td>Supply current Idle mode (4h)</td>
<td>265</td>
<td></td>
<td></td>
<td>µA</td>
</tr>
<tr>
<td></td>
<td>Supply current Continuous mode (5h) or (6h)</td>
<td>650</td>
<td>800</td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td></td>
<td>Supply current Continuous mode (7h)</td>
<td>1</td>
<td>1.2</td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td></td>
<td>Supply current Continuous mode (7h) and temperature sensing</td>
<td>1.1</td>
<td>1.4</td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td>V&lt;sub&gt;POR&lt;/sub&gt;</td>
<td>Power-on reset negative threshold</td>
<td>1.7</td>
<td>1.8</td>
<td>1.82</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td>Hysteresis</td>
<td>50</td>
<td>65</td>
<td>150</td>
<td>mV</td>
</tr>
</tbody>
</table>

1. ADC conversion time is subject to internal clock accuracy.
4 Typical characteristics

\[ T_A = 25 \, ^\circ C \quad V_S = 3.3 \, V, \quad V_{\text{LOAD}} = 48 \, V, \quad V_{\text{IN}+} = V_{\text{IN}-} = 0 \, V, \] unless otherwise stated.

Figure 3. Shunt input offset voltage production distribution \((V_{\text{CM}} = 0 \, V)\)

Figure 4. Shunt input offset voltage production distribution \((V_{\text{CM}} = 48 \, V)\)

Figure 5. Shunt input offset voltage vs. temperature

Figure 6. Common-mode rejection ratio production distribution
Figure 7. Shunt input common-mode rejection ratio vs. temperature

Figure 8. Shunt input gain error production distribution

Figure 9. Shunt input gain error vs. temperature

Figure 10. Shunt input gain error vs. $V_{CM}$

Figure 11. Load input gain error production distribution

Figure 12. Load input gain error vs. temperature
Figure 13. Current consumption (single ADC) vs. temperature

Figure 14. Current consumption (dual ADC) vs. temperature

Figure 15. Shutdown current consumption vs. temperature

Figure 16. Current consumption (dual ADC) vs. power supply voltage

Figure 17. Current consumption (single ADC) vs. power supply voltage

Figure 18. Shutdown current consumption vs. supply voltage
Figure 19. Internal clock vs. power supply

Figure 20. Internal clock frequency vs. temperature
5 Application information

5.1 Overview of TSC1641

The TSC1641 is a digital power monitoring analog front end (AFE) meant to convert parameters such as current, voltage, and temperature and perform power calculation. A digital interface I²C, SMbus or MIPI I3C version 1.1.1 enable the communication to any system requiring an accurate monitoring of such variables. The TSC1641 can convert a shunt resistor voltage to determine the current in the load. The shunt resistor is placed outside the device and can be high-side or low-side, with bidirectional current measurements. The AFE can also monitor the load supply voltage up to 60 V. Current-sensing configurations are shown in Figure 21. There are three paths for each measurement: current, voltage, and temperature, which allows the most optimum computation of the DC power.

Figure 21. Current sensing configurations

The different phases of the measurements are shown below in Figure 22. The user may choose to report through the configuration register, voltage only, current only, temperature only, a combination of these parameters, or all of them.

Figure 22. Voltage, current, power and temperature combinations

The TSC1641 enables a wide range of conversion times, suitable for many applications. The shunt channel and load voltage channel are sampled at the same rate from 128 µs to 32.768 ms. The conversion time is shown below in Figure 23.
5.1.1 High-precision sigma-delta ADC

For very accurate measurement, the TSC1641 integrates two separated channels for the shunt voltage measurement and the load voltage measurement, thus simultaneous sampling is made possible for an optimum device power computation. The input range for the current channel is ±81.92 mV and for the load voltage channel 0 V to 60 V. Each modulator has the same resolution, rated at 16 bits. The modulator is designed in such a way that only increasing the conversion time improves the noise performance of the device, thus simplifying the device configuration for the user.

The noise performances are summarized in Table 5, for each data rate. The effective resolution is given based on the peak-to-peak noise value measured for each setting, which ensures full coverage of the noise distribution.

<table>
<thead>
<tr>
<th>ADC conversion time</th>
<th>Output noise peak to peak (µV)</th>
<th>Noise-free resolution (+/-81.92 mV) p-to-p</th>
</tr>
</thead>
<tbody>
<tr>
<td>128 µs</td>
<td>35</td>
<td>12.2</td>
</tr>
<tr>
<td>256 µs</td>
<td>26.7</td>
<td>12.6</td>
</tr>
<tr>
<td>512 µs</td>
<td>21.7</td>
<td>12.9</td>
</tr>
<tr>
<td>1.024 ms</td>
<td>16.7</td>
<td>13.3</td>
</tr>
<tr>
<td>2.048 ms</td>
<td>12.5</td>
<td>13.7</td>
</tr>
<tr>
<td>4.096 ms</td>
<td>9.2</td>
<td>14.1</td>
</tr>
<tr>
<td>8.192 ms</td>
<td>6.7</td>
<td>14.6</td>
</tr>
<tr>
<td>16.384 ms</td>
<td>3.3</td>
<td>15.7</td>
</tr>
<tr>
<td>32.768 ms</td>
<td>2.5</td>
<td>16</td>
</tr>
</tbody>
</table>

5.1.2 Digital filter

In each conversion channel, the TSC1641 implements a low-noise digital decimation filter to ensure the best noise performance. This digital filter self-adapts to the conversion rate, from 128 µs to 31.7 ms. In Figure 24, the response of the filter is shown for a 128 µs conversion rate.
5.1.3 Negative slew-rate on $V_{\text{Load}}$

The TSC1641 monitors precisely the current and voltage on slow-moving signals. If the load voltage drops with a slew-rate above 80 V/s, the accuracy on the current measurement is transiently degraded above 3%, and performance recovers when the negative slew-rate is in the range supported by the TSC1641.

5.2 Digital interface

The TSC1641 can be addressed through I²C/SMbus or MIPI I3C interface. These protocols are compatible with each other.

SDA and SCL are shared for I²C/SMbus or MIPI I3C. They are open-drain connections to the bus in I²C mode and can be open-drain or push-pull connections in I3C mode. The change from open-drain mode to push-pull mode is done automatically by the TSC1641. The device that initiates communication on the bus is called a controller and generates the clock signal SCL, the START STOP conditions and controls the access to the bus. The devices under control are called targets. The TSC1641 is configured as a target device on the MIPI I3C bus.

The data sent on the digital I²C or MIPI I3C bus are driven MSB first.

5.2.1 Serial bus address

The TSC1641 can be addressed on the bus via an address byte that consists of 7 pre-defined bits and 1 bit to indicate if the device is going to be in read or write mode.

This so-called static address is used automatically on I²C bus and is used optionally on MIPI I3C. With MIPI I3C, despite the controller possibly allocating a virtual address to the devices on the bus (with the dynamic address assignment (DAA)), if a static address exists, it is primary to the virtual address assignment.

Two dedicated input pins, A1, A0 are used to set 4 different addresses. The first 5 MSBs are fixed and the 2 LSBs depend on the state of these pins. Table 6 lists the different states, the corresponding I²C static addresses, and the MIPI I3C PID content. The pins' A1, A0 states must be established before any activity on the bus.

<table>
<thead>
<tr>
<th>A1</th>
<th>A0</th>
<th>Target address (binary)</th>
<th>Target address (h)</th>
<th>Provisional ID (PID) value (h)</th>
</tr>
</thead>
<tbody>
<tr>
<td>GND</td>
<td>GND</td>
<td>1000000</td>
<td>40</td>
<td>0208020A0001</td>
</tr>
<tr>
<td>GND</td>
<td>VS</td>
<td>1000001</td>
<td>41</td>
<td>0208020A1001</td>
</tr>
<tr>
<td>VS</td>
<td>GND</td>
<td>1000010</td>
<td>42</td>
<td>0208020A2001</td>
</tr>
<tr>
<td>VS</td>
<td>VS</td>
<td>1000011</td>
<td>43</td>
<td>0208020A3001</td>
</tr>
</tbody>
</table>
5.2.2 I²C mode

Table 7. I²C target timing characteristics

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter (1)</th>
<th>I²C standard mode (1)</th>
<th>I²C fast mode (1)</th>
<th>I²C fast mode plus</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>f(SCL)</td>
<td>SCL clock frequency</td>
<td>10</td>
<td>100</td>
<td>10</td>
<td>400</td>
</tr>
<tr>
<td>tW(SCLL)</td>
<td>SCL clock low time</td>
<td>4.7</td>
<td>1.3</td>
<td>0.5</td>
<td></td>
</tr>
<tr>
<td>tW(SCLH)</td>
<td>SCL clock high time</td>
<td>4.0</td>
<td>0.6</td>
<td>0.26</td>
<td></td>
</tr>
<tr>
<td>tSU(SDA)</td>
<td>SDA setup time</td>
<td>250</td>
<td>100</td>
<td>50</td>
<td></td>
</tr>
<tr>
<td>tH(SDA)</td>
<td>SDA data hold time</td>
<td>0</td>
<td>3.45</td>
<td>0</td>
<td>0.9</td>
</tr>
<tr>
<td>tH(ST)</td>
<td>START condition hold time</td>
<td>4</td>
<td>0.6</td>
<td>0.26</td>
<td></td>
</tr>
<tr>
<td>tSU(SR)</td>
<td>Repeated START condition setup time</td>
<td>4.7</td>
<td>0.6</td>
<td>0.26</td>
<td></td>
</tr>
<tr>
<td>tSU(SP)</td>
<td>STOP condition setup time</td>
<td>4.0</td>
<td>0.6</td>
<td>0.26</td>
<td></td>
</tr>
<tr>
<td>tW(SP:SR)</td>
<td>Bus free time between STOP and START condition</td>
<td>4.7</td>
<td>1.3</td>
<td>0.5</td>
<td></td>
</tr>
</tbody>
</table>

1. Data based on standard I²C protocol requirement, not tested in production.

Table 8. Switching characteristics for I²C device on I3C bus

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>tLFP</td>
<td>Spike filter in I²C mode device for I3C mixed-bus compatibility (at 12.5 Mhz)</td>
<td></td>
<td></td>
<td>50</td>
<td>ns</td>
</tr>
</tbody>
</table>

Figure 25. I²C timing characteristics
5.2.3 MIPI I3C target interface

Both I²C and I3C are active on the TSC1641. I²C is initiated at startup. To enter the I3C mode, the controller must perform a dynamic address assignment with I²C fast mode plus timing. Once the TSC1641 is addressed, the I²C interface is disabled and the timing is compatible with MIPI I3C specifications.

The TSC1641 includes an MIPI I3C SDR only target interface with MIPI I3C SDR embedded features. Among them, the following features are supported by the TSC1641.

Common codes commands (CCC) are a standardized set of commands that can be transmitted either directly (direct communication) to a specific I3C target device, or to all I3C target devices simultaneously (broadcast communication). This specific address is reserved in I²C, meaning that no legacy I²C component can have this address.

The code for each CCC command is different based on whether they are used as direct or broadcast communication. Refer to Table 11 for the CCC supported by the TSC1641.

The TSC1641 can request hot-join on an I3C bus when it is powered off or physically disconnected from the application with an I3C bus already configured. Before starting a hot-join, the bus must be in an idle state.

The in-band interrupt (IBI) is supported by the TSC1641. If a start condition is done by the controller, the TSC1641 can emit its dynamic address into the arbitrated address header (0x7E) to notify of an interruption. If no start is forthcoming within the bus available condition (> 1 µs after stop), then the TSC1641 may issue a start request by pulling the SDA line low. The controller can accept or reject the IBI using the ACK bit.

The TSC1641 can communicate on multiple bus types. On a legacy I²C bus, the TSC1641 is seen as an I²C target device. On an I3C bus, it can communicate either on a mixed bus where both I3C and legacy I²C devices are present, or on a pure bus whose topology accepts only I3C devices.

Table 9. I3C open-drain timing requirements

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>t_LOW_OD</td>
<td>Low period of SCL clock</td>
<td>200</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_HIGH</td>
<td>High period of SCL clock</td>
<td></td>
<td>41</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_DDA_OD</td>
<td>Fall time of SDA signal</td>
<td></td>
<td>12</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_DRA_OD</td>
<td>Rise time of SDA signal</td>
<td></td>
<td>120</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_SU_OD</td>
<td>SDA data setup time during open-drain mode</td>
<td>3</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_CAS</td>
<td>Clock after start (S) condition</td>
<td>38.4</td>
<td>200</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_CB</td>
<td>Clock before stop (P) condition</td>
<td>19.2</td>
<td>200</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_AVAL</td>
<td>Bus available condition</td>
<td>1</td>
<td></td>
<td></td>
<td>µs</td>
</tr>
<tr>
<td>t_IDLE</td>
<td>Bus idle condition</td>
<td>200</td>
<td></td>
<td></td>
<td>µs</td>
</tr>
</tbody>
</table>

Figure 26. I3C start and stop timings
Table 10. I3C push-pull timing requirements for SDR

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>f_SCL</td>
<td>SCL clock frequency (1)</td>
<td>0.01</td>
<td>12.5</td>
<td>12.9</td>
<td>MHz</td>
</tr>
<tr>
<td>t_LOW</td>
<td>SCL clock low period</td>
<td>24</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_HIGH</td>
<td>SCL clock high period for pure bus and/or mixed bus</td>
<td>24</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>tSCO</td>
<td>Clock in to data out for target</td>
<td></td>
<td>12</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_CR</td>
<td>SCL clock rise time</td>
<td></td>
<td></td>
<td>150x10^6+1/f_SCL (Capped at 60)</td>
<td>ns</td>
</tr>
<tr>
<td>t_CF</td>
<td>SCL clock fall time</td>
<td></td>
<td></td>
<td>150x10^6+1/f_SCL (Capped at 60)</td>
<td>ns</td>
</tr>
<tr>
<td>t_HD_PP</td>
<td>SDA signal data hold in push-pull mode</td>
<td>0</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_SU_PP</td>
<td>SDA signal data setup in push-pull mode</td>
<td>3</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_CASr</td>
<td>Clock after repeated start condition (Sr)</td>
<td>19.2</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t_CBRr</td>
<td>Clock before repeated start (Sr) condition</td>
<td>19.2</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>C_b</td>
<td>Capacitive load per bus line (SDA/SCL)</td>
<td>50</td>
<td></td>
<td></td>
<td>pF</td>
</tr>
</tbody>
</table>

1. \( f_{SCL} = 1 / (t_{DIG_L} + t_{DIG_H}) \)

Figure 27. I3C target device timing characteristics 1/2

[Diagram of I3C target device timing characteristics]

REPEATED START

STOP

0.7 x V_{ref}

0.3 x V_{ref}

SDA

SCL

\( = \) Open Drain with Open Drain Class Pull-Up

\( = \) High Speed active Push-pull Drive
Table 11. MIPI I3C supported commands

<table>
<thead>
<tr>
<th>Command name</th>
<th>Command code</th>
<th>Default</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>ENEC</td>
<td>0x00 / 0x80</td>
<td>On</td>
<td>Enable target event driven interrupts. At startup of the TSC1641, ENEC is enabled by default, which allows hot-join and IBI.</td>
</tr>
<tr>
<td>DISEC</td>
<td>0x01 / 0x81</td>
<td>Off</td>
<td>Disable target event driven interrupts.</td>
</tr>
<tr>
<td>RSTDAA</td>
<td>0x06 / N.A.</td>
<td></td>
<td>Forget current dynamic address and wait for new assignment.</td>
</tr>
<tr>
<td>ENTDAA</td>
<td>0x07 / N.A.</td>
<td></td>
<td>Enter controller initiation of target dynamic address assignment. Do not participate if the target already has an address assigned.</td>
</tr>
<tr>
<td>SETDASA</td>
<td>N.A. / 0x87</td>
<td></td>
<td>Controller assigns a dynamic address to a target with a known static address. Static address is 10000xx depending on A0/A1 in the case of TSC1641.</td>
</tr>
<tr>
<td>SETAASA</td>
<td>0x29 / N.A.</td>
<td></td>
<td>Controller tells every target with a static address to use it as the dynamic address</td>
</tr>
<tr>
<td>Command name</td>
<td>Command code</td>
<td>Default</td>
<td>Description</td>
</tr>
<tr>
<td>--------------</td>
<td>--------------</td>
<td>---------</td>
<td>-------------</td>
</tr>
<tr>
<td>SETNEWDA</td>
<td>N.A. / 0x88</td>
<td></td>
<td>Controller assigns a new dynamic address to any I3C target (only if ENTDAA is supported).</td>
</tr>
<tr>
<td>GETPID</td>
<td>N.A / 0x8D</td>
<td>0x02 0x08 0x02 0x0A 0x0 to 0x3 0x001</td>
<td>Get a target’s provisional ID (ENTDA supported).</td>
</tr>
<tr>
<td>GETBCR</td>
<td>N.A / 0x8E</td>
<td>0x02</td>
<td>Get a device’s bus characteristics register.</td>
</tr>
<tr>
<td>GETDCR</td>
<td>N.A / 0x8F</td>
<td>0x00</td>
<td>Get a device’s device characteristics register.</td>
</tr>
<tr>
<td>GETSTATUS</td>
<td>N.A / 0x90</td>
<td></td>
<td>Get a device’s operating status.</td>
</tr>
<tr>
<td>RSTACT</td>
<td>0x2A / 0x9A</td>
<td></td>
<td>Configure and query target device reset action and timing. 0x00: no action on the target after the reset pattern. 0x01: I3C reset only. 0x02: equivalent to software reset (see Table 12).</td>
</tr>
<tr>
<td>SETGRPA</td>
<td>N.A. / 0x9B</td>
<td></td>
<td>Host assigns a group address to a device. The TSC1641 can be assigned to one group.</td>
</tr>
<tr>
<td>RSTGRPA</td>
<td>0x2C / 0x9C</td>
<td></td>
<td>Host removes a target device from an indicated group address by resetting the assigned group address.</td>
</tr>
<tr>
<td>GETCAPS</td>
<td>N.A. / 0x95</td>
<td></td>
<td>Host asks target device what optional capabilities it supports.</td>
</tr>
</tbody>
</table>
5.3 Register mapping

The registers to be addressed are shown in Table 12. Their addresses are defined by a pointer, an 8-bit register that contains the first register address to be read. During a continuous read, the pointer address is moved automatically to the next register address.

In normal operating mode, the content of the registers can be changed using standard I²C/SMBus or MIPI I3C commands.

### Table 12. Register mapping table

<table>
<thead>
<tr>
<th>Pointer address (hex)</th>
<th>Register name</th>
<th>Type</th>
<th>Default value</th>
<th>Reset after POR</th>
<th>Reset after shutdown mode</th>
<th>Reset after idle mode</th>
<th>Reset after software RST</th>
</tr>
</thead>
<tbody>
<tr>
<td>00h</td>
<td>Configuration register</td>
<td>R/W</td>
<td>0037h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>yes</td>
</tr>
<tr>
<td>01h</td>
<td>Shunt voltage register</td>
<td>R</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>yes</td>
</tr>
<tr>
<td>02h</td>
<td>Load voltage register</td>
<td>R</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>yes</td>
</tr>
<tr>
<td>03h</td>
<td>DC power register</td>
<td>R</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>yes</td>
</tr>
<tr>
<td>04h</td>
<td>Current register</td>
<td>R</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>yes</td>
</tr>
<tr>
<td>05h</td>
<td>Temperature register</td>
<td>R</td>
<td>8000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>yes</td>
</tr>
<tr>
<td>06h</td>
<td>Mask register</td>
<td>R/W</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>yes</td>
</tr>
<tr>
<td>07h</td>
<td>Flag register</td>
<td>R</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>yes</td>
</tr>
<tr>
<td>08h</td>
<td>Rshunt register</td>
<td>R/W</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>no</td>
</tr>
<tr>
<td>09h</td>
<td>SOL alert limit register</td>
<td>R/W</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>no</td>
</tr>
<tr>
<td>0Ah</td>
<td>SUL alert limit register</td>
<td>R/W</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>no</td>
</tr>
<tr>
<td>0Bh</td>
<td>LOL alert limit register</td>
<td>R/W</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>no</td>
</tr>
<tr>
<td>0Ch</td>
<td>LUL alert limit register</td>
<td>R/W</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>no</td>
</tr>
<tr>
<td>0Dh</td>
<td>POL alert limit register</td>
<td>R/W</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>no</td>
</tr>
<tr>
<td>0Eh</td>
<td>TOL alert limit register</td>
<td>R/W</td>
<td>0000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>no</td>
</tr>
<tr>
<td>FEh</td>
<td>Manufacturing ID</td>
<td>R</td>
<td>0006h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>no</td>
</tr>
<tr>
<td>FFh</td>
<td>Die ID register</td>
<td>R</td>
<td>1000h</td>
<td>yes</td>
<td>no</td>
<td>no</td>
<td>no</td>
</tr>
</tbody>
</table>

#### 5.3.1 Configuration register (00h) read/write

### Table 13. Configuration register (00h) read/write

<table>
<thead>
<tr>
<th>Bit n°</th>
<th>15</th>
<th>14</th>
<th>13</th>
<th>12</th>
<th>11</th>
<th>10</th>
<th>9</th>
<th>8</th>
<th>7</th>
<th>6</th>
<th>5</th>
<th>4</th>
<th>3</th>
<th>2</th>
<th>1</th>
<th>0</th>
</tr>
</thead>
<tbody>
<tr>
<td>Name</td>
<td>RST</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>POR value</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>1</td>
<td>0</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td></td>
</tr>
</tbody>
</table>

RST: When this bit is set high, it generates a system reset. Some of the registers are reset as shown in the register mapping Table 12. Register mapping table. The RST bit is self-cleared.

CT3 to CT0: conversion time for both shunt and load voltage channels.

### Table 14. CT3 to CT0: conversion time

<table>
<thead>
<tr>
<th>CT3</th>
<th>CT2</th>
<th>CT1</th>
<th>CT0</th>
<th>Conversion time</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>128 µs</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>256 µs</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>1</td>
<td>0</td>
<td>512 µs</td>
</tr>
</tbody>
</table>
TEMP: this bit turns on the temperature sensor when set to a high level and turns off the temperature sensor when set to a low level. Temperature sensing can only be done in the normal operating modes (thus excluding shutdown and idle mode). Temperature is sensed in a continuous way at a fixed conversion rate of 8.192 ms. When no temperature measurement is performed, the temperature register (05 h) returns the to code 8000 (h).

M2 to M0: all the different modes that are available.

<table>
<thead>
<tr>
<th>Table 15. M2 to M0: operating modes of the TSC1641</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>M2</strong></td>
</tr>
<tr>
<td>0</td>
</tr>
<tr>
<td>0</td>
</tr>
<tr>
<td>0</td>
</tr>
<tr>
<td>0</td>
</tr>
<tr>
<td>1</td>
</tr>
<tr>
<td>1</td>
</tr>
<tr>
<td>1</td>
</tr>
<tr>
<td>1</td>
</tr>
</tbody>
</table>
In this mode, shunt and load voltages are measured simultaneously at the conversion time defined in the configuration register with the bits CT3-CT0. If the specific Rshunt register is correctly filled, then the power can be computed.

Default power-up mode: when TSC1641 is switched on, applying a proper power supply on VS, the device automatically enters the default configuration, meaning that it starts I²C mode and converts continuously the current and load voltage at a 1024 µs conversion time. First valid data is available after 3 clock cycles of 128 µs and one cycle of 1024 µs. The CVNR bit from the MASK register is set to high to inform the user about the availability of the data.

5.3.2 Shunt voltage measurement register (01h) read-only
This read-only register stores the value measured on the shunt resistor. Positive value is binary: positive full-scale goes from 0000(h) to 7FFF (hex). Negative value is two’s complement. Negative full-scale goes from 8000(h) (two's complement of decimal -32767 to 000(h)).

If the register returns either 7FFF or 8000, together with the bit SATF set to ‘1’, the shunt voltage is out of the input range of the TSC1641.

If the shunt voltage is not measured (mode 2h or 6h), the value returned by the shunt voltage register is 0, as well as the ones of the current and power registers.

Bit 15: sign.
Bit 14-0: value referred to shunt-LSB: 2.5 µV.

5.3.3 Load voltage measurement register (02h) read-only
This read-only register contains the measurement of the load supply voltage. The LSB_load is 2 mV and full-scale 7FFF is 65.534V. Please refer to the operating conditions table to get the recommended voltage range supported on Vload.

If the register returns 0000(h) or 7FFF(h) with SATF set to ‘1’, the load voltage is out of the input range of the TSC1641.

If the load voltage is not measured (mode 1h or 5h), the value returned by the load voltage register is 0 as well as the one of the computed power register.

5.3.4 Current register (03h) read-only
This register contains the value of the current flowing into the shunt. The value is given from an internal calculation using the Rshunt register. If no information has been set in the Rshunt register, then the current register returns to 0.

5.3.5 Power register (04h) read-only
This register contains the value of the computed DC power. Voltage and current are measured simultaneously to compute the power accurately. To have an adequate value, the Rshunt register must be filled in, otherwise, the power register returns to 0.

5.3.6 Temperature register (05h) read-only
An internal temperature sensor releases upon demand the temperature of the TSC1641. The bit TEMP in the configuration register is set to “1”. The controller must read the register (16-bit wide) in two’s complement format. The temperature can be read within the range of -40 °C to 125 °C. Outside this window, the values are not representative of a physical quantity. A 0.5 °C/LSB resolution is implemented.

To get a simple value of the temperature, the user simply must take the decimal number of the register and divide it by a factor of two. For simplification, the register is symmetrical, and the code 0000 (h) represents 0 °C.

Examples:
Code: 0032(h) is 50 (dec), thus, after division by 2 is +25 °C
Code: 00AA(h) is 170 (dec) thus, after division by 2 is +85 °C
Code: FFD8(h) is -40 (dec) thus, after division by 2 is -20 °C
If the register returns 8000(h), the TEMP bit was not set.
5.3.7 Mask register (06h) read/write

The mask register selects the function that is enabled to control the alert pin and the functionality of the alert pin. There is one alert limit register per functionality. If multiple features are enabled, the alert pin is asserted based on priority of the bit with the highest significance (D15-D10).

Table 16. Mask register

<table>
<thead>
<tr>
<th>Bit n°</th>
<th>15</th>
<th>14</th>
<th>13</th>
<th>12</th>
<th>11</th>
<th>10</th>
<th>9</th>
<th>8</th>
<th>7</th>
<th>6</th>
<th>5</th>
<th>4</th>
<th>3</th>
<th>2</th>
<th>1</th>
<th>0</th>
</tr>
</thead>
<tbody>
<tr>
<td>Name</td>
<td>SOL</td>
<td>SUL</td>
<td>LOL</td>
<td>LUL</td>
<td>POL</td>
<td>TOL</td>
<td>CVNR</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>APOL</td>
<td></td>
<td>ALEN</td>
</tr>
<tr>
<td>POR value</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td></td>
</tr>
</tbody>
</table>

These register bits select which parameter controls the alert pin (I²C) or the IBI (MIPI I3CSM). One 16-bit register threshold is associated to each mask bit.

SOL: shunt voltage over limit
Setting this bit high configures the ALERT pin to be asserted if the shunt voltage measurement following a conversion exceeds the value programmed in the SOL alert limit register.

SUL: shunt voltage under limit
Setting this bit high configures the ALERT pin to be asserted if the shunt voltage measurement following a conversion drops below the value programmed in the SUL alert limit register.

LOL: load voltage over limit
Setting this bit high configures the ALERT pin to be asserted if the load voltage measurement following a conversion exceeds the value programmed in the LOL alert limit register.

LUL: load voltage under limit
Setting this bit high configures the ALERT pin to be asserted if the load voltage measurement following a conversion drops below the value programmed in the LUL alert limit register.

POL: power over limit
Setting this bit high configures the ALERT pin to be asserted if the power calculation following a load voltage measurement exceeds the value programmed in the POL alert limit register.

TOL: temperature over limit
Setting this bit high configures the ALERT pin to be asserted if temperature measurement following a conversion exceeds the value programmed in the TOL alert limit register.

CVNR: conversion_ready
Setting this bit high configures the ALERT pin to be asserted when the conversion ready flag (CVNF) of the flag register is asserted, indicating that the device is ready for the next conversion.

APOL: alert polarity bit
Setting this bit high configures the polarity of the ALERT pin to be inverted and active high open-drain.
Setting this bit low configures the normal polarity of the ALERT pin, being active low open-drain.

ALEN: alert latch enable
When set to 0, transparent mode is enabled, the ALERT pin and corresponding fault bit in flag register is reset to default value once fault has been cleared. The ALEN bit does not apply to the CVNR bit.
When set to 1, latch mode is enabled, the ALERT pin and corresponding fault bit remain active following a fault until the flag register has been read.

5.3.8 Flag register (07h) read-only

The flag register is a read-only register that sets the flag bit high either automatically for OVF, SATF or when the selected function in the mask register has been set.

Table 17. Flag register

<table>
<thead>
<tr>
<th>Bit n°</th>
<th>15</th>
<th>14</th>
<th>13</th>
<th>12</th>
<th>11</th>
<th>10</th>
<th>9</th>
<th>8</th>
<th>7</th>
<th>6</th>
<th>5</th>
<th>4</th>
<th>3</th>
<th>2</th>
<th>1</th>
<th>0</th>
</tr>
</thead>
<tbody>
<tr>
<td>Name</td>
<td>OVF</td>
<td>SATF</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>SOF</td>
<td>SUF</td>
<td>LOF</td>
<td>LUF</td>
<td>POF</td>
<td>TOF</td>
<td>CVNF</td>
</tr>
<tr>
<td>POR value</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td></td>
</tr>
</tbody>
</table>
OVF: math overflow flag
This bit is set high if an arithmetic operation resulted in an overflow error. It indicates that current or power data may be invalid. OVF is cleared when arithmetic operation leads to valid data.

SATF: saturation flag
This flag is internally set high when the signal under measurement is outside the input allowable range. It may be set high in the following conditions:
- $V_{shunt} < -81.9175 \text{ mV}$ or $+81.92 \text{ mV} < V_{shunt}$
- $7FFFF(h) < V_{load}$
The SATF does not trigger the alert pin in I²C or IBI in I3C.
The SATF bit is cleared if measurement is back to the allowable input range.

SOF: shunt overvoltage flag
This flag is internally set to high when the SOL bit of mask register is set to high and shunt voltage measurement following a conversion exceeds the SOL alert limit register. The SOF bit is cleared after reading the alert flag register.

SUF: shunt undervoltage flag
This flag is internally set to high when the SUL bit of mask register is set to high and shunt voltage measurement following a conversion drops below the SUL alert limit register. The SUF bit is cleared after reading the alert flag register.

LOF: load overvoltage flag
This flag is internally set to high when the LOL bit of mask register is set to high and load voltage measurement following a conversion exceeds the LOL alert limit register. The LOF bit is cleared after reading the alert flag register.

LUF: load undervoltage flag
This flag is internally set to high when the LUL bit of mask register is set to high and voltage measurement following a conversion drops below the LUL alert limit register. The LUF bit is cleared after reading the alert flag register.

POF: over power flag
This flag is internally set to high when the POL bit of mask register is set to high and power following a calculation exceeds the POL alert limit register. The POF bit is cleared after reading the alert flag register.

TOF: overtemperature flag
This flag is internally set to high when the TOL bit of mask register is set to high and temperature measurement following a conversion exceeds the TOL alert limit register. The TOF bit is cleared after reading the alert flag register.

CVNF: conversion ready flag
Although the device can be read at any time, and the data from the last conversion is available, the conversion ready flag can help to coordinate one-shot or triggered conversions. The CVNF bit is set each time a new data is entered into a register. The CVNF is cleared under the following conditions:
- Writing to the configuration register (except for the shutdown and idle mode selection)
- Reading the flag register

5.3.9 Rshunt register (08h) read/write

| Bit n° | 15 | 14 | 13 | 12 | 11 | 10 | 9  | 8  | 7  | 6  | 5  | 4  | 3  | 2  | 1  | 0  |
|--------|----|----|----|----|----|----|----|----|----|----|----|----|----|----|----|
| POR value | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  |

The Rshunt register (16-bit wide) stores the value of the Rshunt resistor placed in the application. The user enters the Rshunt value based on the current flowing into the application.

Rshunt_LSB is 10 μΩ, therefore the values could be entered from 0 Ω to 655.35 mΩ, but we recommend this range of values for Rshunt: 800 μΩ (Imax = 102 A) to 655.35 mΩ (Imax = 125 mA).

We remind the user that: $V_{shunt\_LSB} = 2.5 \mu\text{V}$, $V_{load\_LSB} = 2 \text{ mV}$. And the DCpower_LSB is set to 25 mW.

Maximum allowed DC power on TSC1641 is 1600 W.

Figure 29 shows an example of an application with $I_{max} = 20 \text{ A}$, $V_{Batt} = 12 \text{ V}$, $I_{load} = 8 \text{ A}$.
The first option for the user is to optimize the acquisition channel to full-scale +/-81.92 mV. Rshunt is defined by 81.92 mV / 20 A = 4.096 mΩ. Based on normalized values, the user may choose between Rshunt 4 mΩ to 4.1 mΩ. Let us assume that the user chooses Rshunt = 4 mΩ, the digital value is Rshunt (dig) = 400 (dec) thus the Rshunt register value is: 0190 (hex).

The LSB in current is then: I_LSB = Vshunt_LSB/Rshunt, thus, I_LSB = 625 µA.

The reading of the registers then gives:
- Shunt voltage: 3200 (hex) which is 12800 (dec), then 12800 (dec) * 2.5 µV = 32 mV
- Load voltage: 1770 (hex) which is 6000 (dec), then 6000 (dec) * 2 mV = 12 V
- DC power: 0F00 (hex), which is 3840 (dec), then 3840 (dec) * 25 mW = 96 W
- Current: 3200 (hex) which is 12800 (dec), then 12800 (dec) * 6.25 µA = 8 A

The second option for the user is to get a simple distinctive current_LSB: say I_LSB = 1 mA, thus Rshunt = Vshunt_LSB/I_LSB = 2.5 mΩ.

In this case the maximum full-scale is 20 A * 2.5 mΩ = 50 mV.

The registers reading should give:
- Shunt voltage: 1F80 (hex) which is 8000 (dec), then 8000 (dec) * 2.5 µV = 20 mV
- Load voltage: 1770 (hex) which is 6000 (dec), then 6000 (dec) * 2 mV = 12 V
- DC power: 0F00 (hex), which is 3840 (dec), then 3840 (dec) * 25 mW = 96 W
- Current: 1F80 (hex) which is 8000 (dec), then 8000 (dec) * 1 mA = 8 A

If no value is entered in the the Rshunt register, then the default value of Rshunt is 0, and the reading of the current register and the power register returns to 0.

5.3.10 Register SOL alert limit (09h) read-write
The user can write in the shunt over limit register the threshold voltage above which the alert is active. The SOL LSB is 2.5 µV.

| Bit n° | 15 | 14 | 13 | 12 | 11 | 10 | 9  | 8  | 7  | 6  | 5  | 4  | 3  | 2  | 1  | 0  |
|--------|----|----|----|----|----|----|----|----|----|----|----|----|----|----|----|
| POR value | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  |

5.3.11 Register SUL alert limit (0Ah) read-write
The user can write in the shunt under limit register the threshold voltage below which the alert is active. The SUL LSB is 2.5 µV.
5.3.12 **Register LOL alert limit (0Bh) read-write**
The user can write in the load over limit register the threshold voltage above which the alert is active. The LOL LSB is 2 mV.

<table>
<thead>
<tr>
<th>Bit n°</th>
<th>15</th>
<th>14</th>
<th>13</th>
<th>12</th>
<th>11</th>
<th>10</th>
<th>9</th>
<th>8</th>
<th>7</th>
<th>6</th>
<th>5</th>
<th>4</th>
<th>3</th>
<th>2</th>
<th>1</th>
<th>0</th>
</tr>
</thead>
<tbody>
<tr>
<td>POR value</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
</tr>
</tbody>
</table>

5.3.13 **Register LUL alert limit (0Ch) read-write**
The user can write in the load over limit register the threshold voltage above which the alert is active. The LOL LSB is 2 mV.

<table>
<thead>
<tr>
<th>Bit n°</th>
<th>15</th>
<th>14</th>
<th>13</th>
<th>12</th>
<th>11</th>
<th>10</th>
<th>9</th>
<th>8</th>
<th>7</th>
<th>6</th>
<th>5</th>
<th>4</th>
<th>3</th>
<th>2</th>
<th>1</th>
<th>0</th>
</tr>
</thead>
<tbody>
<tr>
<td>POR value</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
</tr>
</tbody>
</table>

5.3.14 **Register POL alert limit (0Dh) read-write**
The user can write in the power over limit register the threshold voltage above which the alert is active. The POL LSB is 25 mW.

<table>
<thead>
<tr>
<th>Bit n°</th>
<th>15</th>
<th>14</th>
<th>13</th>
<th>12</th>
<th>11</th>
<th>10</th>
<th>9</th>
<th>8</th>
<th>7</th>
<th>6</th>
<th>5</th>
<th>4</th>
<th>3</th>
<th>2</th>
<th>1</th>
<th>0</th>
</tr>
</thead>
<tbody>
<tr>
<td>POR value</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
</tr>
</tbody>
</table>

5.3.15 **Register TOL alert limit (0Eh) read-write**
The user can write in the temperature over limit register the threshold voltage above which the alert is active. The POL LSB is 0.5 °C.

<table>
<thead>
<tr>
<th>Bit n°</th>
<th>15</th>
<th>14</th>
<th>13</th>
<th>12</th>
<th>11</th>
<th>10</th>
<th>9</th>
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<th>6</th>
<th>5</th>
<th>4</th>
<th>3</th>
<th>2</th>
<th>1</th>
<th>0</th>
</tr>
</thead>
<tbody>
<tr>
<td>POR value</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
</tr>
</tbody>
</table>

5.3.16 **Manufacturer register (FEh) read-only**
This register is accessible through standard read command and reports the STMicroelectronics ID which is 0006h.

5.3.17 **Die ID register (FFh) read-only**
This register is accessible through a standard read command. Die ID is 1000h.
5.4  Typical application circuit

Figure 30. Typical application for high-side sensing and MIPI I3C communication

Figure 30 shows a typical configuration used when connecting the device to a controller with MIPI I3C interface. The pads A0/A1 are used in our case to set the provisional identification register (PID) accessed by the command ‘GETPID’ in Table 6. SDA and SCL are directly connected to the controller, no pull-up resistor is needed. The ALERT/DRDY pad is unused in I3C mode. Instead, the IBI (in-band interrupt) plays the role of the interrupt. This configuration is a standard high-side current measurement with a load supplied by a voltage up to 60 V.

5.5  Layout recommendation

5.5.1  Shunt resistor layout
The shunt resistor layout must be designed carefully to guarantee the best performance. The kelvin connection must be used to ensure that only the shunt resistor impedance is sensed between the inputs.
Length of IN+ and IN- traces must be precisely balanced to keep the shunt offset voltage low.

**Figure 31. Shunt resistor layout**

5.5.2 **100 nF decoupling capacitor placement**
To guarantee the best performance, the C2 decoupling capacitor must be placed very close to the circuit, at 5 mm from the circuit center, as shown in Figure 32. The layout recommendation must be followed precisely. We recommend using a 100 nF for C2 in 0603 format.

A ground plane must be present under the circuit.

**Figure 32. TSC1641 layout**
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.
6.1 DFN10 (3x3 mm) package information

Figure 33. DFN10 (3x3 mm) package outline
### Table 25. DFN10 (3x3 mm) mechanical data

<table>
<thead>
<tr>
<th>Dim.</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
</tr>
</thead>
<tbody>
<tr>
<td>A</td>
<td>0.80</td>
<td>0.90</td>
<td>1.00</td>
</tr>
<tr>
<td>A1</td>
<td>0</td>
<td>0.02</td>
<td>0.05</td>
</tr>
<tr>
<td>A3</td>
<td>-</td>
<td>0.203 Ref.</td>
<td>-</td>
</tr>
<tr>
<td>b</td>
<td>0.20</td>
<td>0.25</td>
<td>0.30</td>
</tr>
<tr>
<td>D</td>
<td>3.00 BSC</td>
<td>0.25</td>
<td>0.30</td>
</tr>
<tr>
<td>D2</td>
<td>0.15</td>
<td>0.25</td>
<td>0.30</td>
</tr>
<tr>
<td>E</td>
<td>3.00 BSC</td>
<td>1.40</td>
<td>1.60</td>
</tr>
<tr>
<td>E2</td>
<td>1.40</td>
<td>1.50</td>
<td>1.60</td>
</tr>
<tr>
<td>e</td>
<td>0.50 BSC</td>
<td>0.20</td>
<td>-</td>
</tr>
<tr>
<td>K</td>
<td>0.20</td>
<td>-</td>
<td>-</td>
</tr>
<tr>
<td>L</td>
<td>0.90</td>
<td>1.00</td>
<td>1.10</td>
</tr>
<tr>
<td>aaa</td>
<td>0.05</td>
<td></td>
<td></td>
</tr>
<tr>
<td>bbb</td>
<td>0.10</td>
<td></td>
<td></td>
</tr>
<tr>
<td>ccc</td>
<td>0.10</td>
<td></td>
<td></td>
</tr>
<tr>
<td>ddd</td>
<td>0.05</td>
<td></td>
<td></td>
</tr>
<tr>
<td>eee</td>
<td>0.08</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

### Figure 34. DFN10 (3x3 mm) recommended footprint
## Ordering information

### Table 26. Order codes

<table>
<thead>
<tr>
<th>Order code</th>
<th>Package</th>
<th>Packaging</th>
<th>Marking</th>
</tr>
</thead>
<tbody>
<tr>
<td>TSC1641IQT</td>
<td>DFN10</td>
<td>Tape &amp; Reel</td>
<td>1641</td>
</tr>
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</table>
## Revision history

**Table 27. Document revision history**

<table>
<thead>
<tr>
<th>Date</th>
<th>Revision</th>
<th>Changes</th>
</tr>
</thead>
<tbody>
<tr>
<td>12-Sep-2023</td>
<td>1</td>
<td>Initial release.</td>
</tr>
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<td>Table 16</td>
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<td>Table 17</td>
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<td>21</td>
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<tr>
<td>Table 18</td>
<td>RsHunt register</td>
<td>22</td>
</tr>
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<td>Table 19</td>
<td>Register SOL</td>
<td>23</td>
</tr>
<tr>
<td>Table 20</td>
<td>Register SUL</td>
<td>24</td>
</tr>
<tr>
<td>Table 21</td>
<td>Register LOL</td>
<td>24</td>
</tr>
<tr>
<td>Table 22</td>
<td>Register LOL</td>
<td>24</td>
</tr>
<tr>
<td>Table 23</td>
<td>Register POL</td>
<td>24</td>
</tr>
<tr>
<td>Table 24</td>
<td>Register POL</td>
<td>24</td>
</tr>
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<tr>
<td>Table 26</td>
<td>Order codes</td>
<td>30</td>
</tr>
<tr>
<td>Table 27</td>
<td>Document revision history</td>
<td>31</td>
</tr>
</tbody>
</table>
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